

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/566,506	ABE ET AL.	
Examiner	Art Unit	
ANH H DO	2624	

	SEAR	CHED	
Class	Subclass	Date	Examiner
382	232, 233, 236 ,238, 239, 275,	4/27/2009	AD
	162, 166		
375	240.27,		
	E7.135		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM EAST (US) EAST (EPO, JPO) EAST (US-PG PUB)	4/27/2009	AD